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ELECTRONIC COMPONENTS GROUP
SHARP CORPORATION

SPECIFICATION

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REPRESENTATIVE DIVISION	
<input checked="" type="checkbox"/> ELECTRONIC COMPONENTS DIV.	
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DEVICE SPECIFICATION FOR
RF UNIT FOR CORDLESS PHONE
(PORTABLE SET)
MODEL NO. RY3G11020
(A3RY3GIIA10)

• CUSTOMER'S APPROVAL

DATE

BY

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MODEL No.

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RECORDS OF REVISION

DATE	REF. PAGE PARAGRAPH DRAWING No.	REVISED No	SUMMARY	CHECK & APPROVAL
10. APR. 1995	P16	△	Altered 2-4 Wrapping details Fig.4	<i>A. Totuda</i>

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Description : This specification covers RF UNIT intended for use in Cordless
Phone Portable unit.

[1] GENERAL SPECIFICATIONS

1- 1 Frequency range	Transmitting freq. 914. 0125MHz to 914. 9875MHz
	Receiving freq. 959. 0125MHz to 959. 9875 MHz
1-2 Communication system	Duplex
1-3 Number of channel	40 ch
1-4 Nominal input and output impedance	50 Ω
1-5 Intermediate frequency	1st IF 21. 7MHz 2nd IF 450 KHz
1-6 Modulation system	Analog FM
1-7 Operating voltage	3. 3V to 5. 0V (internal Regulator ICout:3.0V)
1-8 Absolute maximum supply voltage (Ta=25℃)	6. 0V
1-9 Weight	26g
1-10 Block diagram	Figure 1

[2] MECHANICAL SPECIFICATIONS

2- 1 Dimension and mounting details	Figure 2
2-2 Terminal details	Table 1
2-3 Measurement connection circuit	Figure 3
2-4 Wrapping details	Figure 4

SHARP**[3] ENVIRONMENT SPECIFICATIONS**

3- 1 Operating guarantee temperature	0℃ to 55℃ (Guarantee items) ● Transmitting freq. inaccuracy ● Transmitting output power “Carrier detect time (adjacent channel select) ● PLL lock up time (adjacent channel select)
3- 2 Efficient guarantee temperature	25℃ +15/-10℃ (Guarantee items) “Except 3-1 items
3- 3 Storage temperature	-20℃ to 70℃
3- 4 Operating humidity	Less than 85%
3- 5 Storage humidity	Less than 90%

【4】 TESTING CONDITIONS

4- 1 Supply voltage	3. 6V ±0.3V
4- 2 Ambient temperature	25℃ +15/-10℃
4- 3 Ambient humidity	20%~75%

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[5] ELECTRICAL SPECIFICATIONS (Ta: 25°C±15/-10°C)

*5-1-5-18,5-21,5-22 --- PLL IC : Normal operating mode

*5-10-5-13 --- Measured at connecting circuit figure 3 (COMPANDER Recommendation G162)

*5-4, 5, 8, 10,11,12,13,15,16 --- CCITT : Measured with CCITT filter

(CCITT Recommendation P53A)

NO.	Item	Specification			Unit	Condition
		Min.	Typ	Max.		
TX BLOCK						
5-1	Transmitting freq. inaccuracy			±1.0	kHz	
		at 24°C ~ 26°C		±2.5		
	at 0°C ~ 55°C					
5-2	Transmitting output power	8.0	11	14	dBm	Ta: 0°C to 55°C
5-3	Standard modulation level	100		240	mVrms	1kHz mod., 3kHz o-p dev., 600Ω term
5-4	Modulation S/N	45			dB	CCITT
5-5	Transmitting total distortion & noise	35	40		dB	CCITT
5-6	Modulation frequency response			+1.0	dB	REF: 1kHz
		at 300Hz	-1.0	+1.0		
	at 3kHz	-1.0		+1.0		
5-7	Spurious transmission			-54	dBm	Point: TX output terminal
		at 0 ~ 1GHz		-36		
		at 1 ~ 4GHz		-77		
	at 87.5 ~ 108MHz					
RX BLOCK						
5-8	Receiving sensitivity			-106	dBm	CCITT at SINAD 20dB point
5-9	Radiation interference			-57	dBm	Point: RX output terminal Transmitting-circuits OFF (TX OFF)
		at 0 ~ 1GHz		-47		
		at 1 ~ 4GHz		-77		
	at 87.5 ~ 108MHz					
5-10	Co-channel rejection	-14			dB	CCITT Desire input level: -102dBm fm: 1kHz, dev: 3kHz o-p Undesire input level : at SINAD 20dB point, fm: 400Hz dev: 3kHz o-p Measured at connecting circuit figure 3.
5-11	Adjacent channel selectivity	51			dB	CCITT Desire input level: -102dBm fm: 1kHz, dev: 3kHz o-p Undesire input freq : fo±25kHz, input level : at SINAD 20dB point, fm: 400Hz dev: 3kHz o-p Measured at connecting circuit figure 3.

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5-	Spurious response rejection	56		dB	<p>CCITT Desire input level: -102dB fm: 1kHz, dev: 3kHz 0 - p Undesire input freq : 30 MHz to 2GHz, fm: 400Hz, dev: 3kHz 0 - p input level : at SINAD 20dB point Measured at connecting circuit figure 3.</p>
5-1	Intermodulation rejection	51		dB	<p>CCITT Desire input level: -102dBm fm: 1kHz, dev: 3kHz 0 - p Undesire 1 input level: at SINAD 20dB point, input freq: fo±25kHz Undesire 2 input level: at SINAD 20dB point, input freq: fo±50kHz, fm: 400Hz, dev: 3kHz 0 - p Measured at connecting circuit figure 3.</p>
		56			<p>CCITT Desire input level: -102dBm fm: 1kHz dev: 3kHz 0 - p Undesire 1 input level: at SINAD 20dB point input freq: fo±50kHz Undesire 2 input level: at SINAD 20dB point input freq: fo±100kHz fm: 400 Hz, dev: 3kHz 0 - p Measured at connecting circuit figure 3.</p>

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5-14	Standard demodulation level	90		170	mVrms	Input level: -53dBm, LPF:30kHz, 100kΩ term	
5-15	Demodulation S/N	45			dB	Input level: -53dBm, CCITT	
5-16	Receiving total distortion & noise	35	40		dB	Input level:-53dBm, CCITT	
5-17	Demodulation frequency response	at 500Hz	-2.0	+2.0	dB	Input level :-53dBm, LPF:30KHz REF: 1KHz	
		at 2.2KHz	-3.0	0			
5-18	Carrier detect level		-116	-114	-112	dBm	C/S:H+L (at 20ch 25℃) fm:1KHz,dev:3KHz 0-p
		hysterisys width		2	4	dB	
5-19	Carrier detect time (adjacent channel select)		15	40	ms	PLL IC:High speed mode fm:1KHz, dev:3KHz 0-p Ta:0℃ to 55℃	
(TOTAL BLOCK)							
5-20	PLL lock up time (adjacent channel select)		5	20	ms	PLL IC:High speed mode Ta:0℃ to 55℃	
5-21	Current consumption	Speech		110	mA	at PLL locked	
		Stanby		60			
5-22	INPUT VSWR		1.5	2.5		impedance : 50Ω TX+B1 "OPEN" TX+B2 " L "	



[61 PLL Channel selection operating data

6-1 Input data

(1) Setting RX-PLL division data

MSB

H	L	D ₁₆	D ₁₅	D ₁₄	D ₁₃	D ₁₂	D ₁₁	D ₁₀	D ₉	D ₈	D ₇	D ₆	D ₅	D ₄	D ₃	D ₂	D ₁	D ₀
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$$N = D_{16} \times 2^{16} + D_{15} \times 2^{15} + D_{14} \times 2^{14} + \dots + D_1 \times 2^1 + D_0 \times 2^0$$

$$= (f_{RX} + 21.7 \times 10^6) / 12.5 \times 10^3$$

$$= 78457 \text{ - } 78535$$

f_{RX}: Frequency of RX --959.0125-959. 9875MHz

(2) Setting TX-PLL division data

MSB

LSB

L	H	D ₁₆	D ₁₅	D ₁₄	D ₁₃	D ₁₂	D ₁₁	D ₁₀	D ₉	D ₈	D ₇	D ₆	D ₅	D ₄	D ₃	D ₂	D ₁	D ₀
---	---	-----------------	-----------------	-----------------	-----------------	-----------------	-----------------	-----------------	----------------	----------------	----------------	----------------	----------------	----------------	----------------	----------------	----------------	----------------

$$N = D_{16} \times 2^{16} + D_{15} \times 2^{15} + D_{14} \times 2^{14} + \dots + D_1 \times 2^1 + D_0 \times 2^0$$

$$= f_{TX} / 12.5 \times 10^3$$

$$= 73121 \text{ - } 73199$$

f_{TX}: Frequency of TX --914.0125-914. 9875MHz

[For example]

If setting TX-PLL division data at 914. 0125MHz

$$914.0125 \times 10^6 / 12.5 \times 10^3 = (73121)_{10} = (10001110110100001)_2$$

L	H	D ₁₆	D ₁₅	D ₁₄	D ₁₃	D ₁₂	D ₁₁	D ₁₀	D ₉	D ₈	D ₇	D ₆	D ₅	D ₄	D ₃	D ₂	D ₁	D ₀
L	H	H	L	L	L	H	H	H	L	H	H	L	H	L	L	L	L	H

(3) Setting Reference division data

MSB

LSB

H	H	D ₁₁	D ₁₀	D ₉	D ₈	D ₇	D ₆	D ₅	D ₄	D ₃	D ₂	D ₁	D ₀
---	---	-----------------	-----------------	----------------	----------------	----------------	----------------	----------------	----------------	----------------	----------------	----------------	----------------

$$N = D_{11} \times 2^{11} + D_{10} \times 2^{10} + D_9 \times 2^9 + \dots + D_1 \times 2^1 + D_0 \times 2^0$$

$$= 3400 \text{ (Fixed)}$$

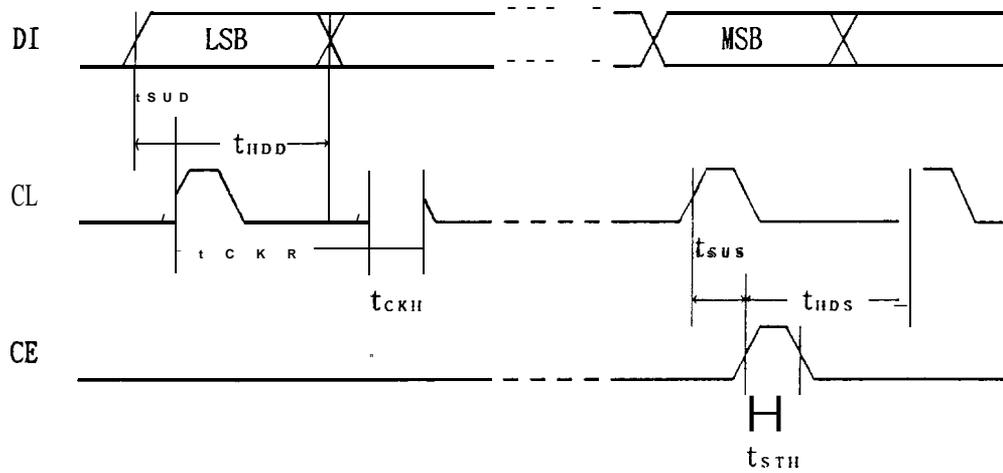
[Setting]

$$N = (3400), 0 = (110101001000)_2$$

H	H	D ₁₁	D ₁₀	D ₉	D ₈	D ₇	D ₆	D ₅	D ₄	D ₃	D ₂	D ₁	D ₀
H	H	H	H	L	H	L	H	L	L	H	L	L	L

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6-2 Timing chart



Items	Symbols	Electronic characteristics
Set up time of "DI"	t_{SUD}	$t_{SUD} \geq 0.1 \mu S$
Hold time of "DI"	t_{HDD}	$t_{HDD} \geq 1.0 \mu S$
Rate of "CL"	t_{CKR}	$t_{CKR} \geq 5.0 \mu S$
High level time of "CL"	t_{CKH}	$t_{CKH} \geq 1.0 \mu S$
Set up time of "CE"	t_{SUS}	$t_{SUS} \geq 0.1 \mu S$
Hold time of "CE"	t_{HDS}	$t_{HDS} \geq 1.0 \mu S$
High level time of "CE"	t_{STH}	$t_{STH} \geq 1.0 \mu S$

6-3 Input voltage(DI, CL, CE)

Input	min.	max.
"H" level	2.5V	3.1V
"L" level	-0.2V	0.5V

7-1 Vibration test

This test is proceed on at least one hour in shelf after vibration test loaded one minute of 1.5mm amplitude toward X, Y and Z direction for two hours of one □ inute of 10 to 55 / one minute cycle of vibration.

After above testing, samples are left at normal temperature and humidity for 24hours. And then, they should be kept the normal operations according to the standard values of judgement (B) on Table 7

7-2 Drop test

This test is dropping from 1.0m high on wood board of 3cm in thick of 20 x 20cm, but not applied for the lead wire and also the drop from the box surface.

After above testing, samples are left at normal temperature and humidity for 24hours. And then, they should be kept the normal operations according to the standard values of judgement (B) on Table 7.

		(A)	(B)
(1)	Transmitting frequency inaccuracy	±2.5kHz	±5.0kHz
(2)	Transmitting output power	11±3.0dBm	11±5.0dBm
(3)	Receiving sensitivity	-----	(initial value) ±10dB
(4)	Carrier detect time	40ms MAX.	(initial value) ±20ms
(5)	PLL lock up time	20ms MAX.	(initial value) ±20ms

Table 7 Standard values of judgement

Standard (A) is only applied to measurement of characteristics with temperature change. (operating range : 0~55℃)

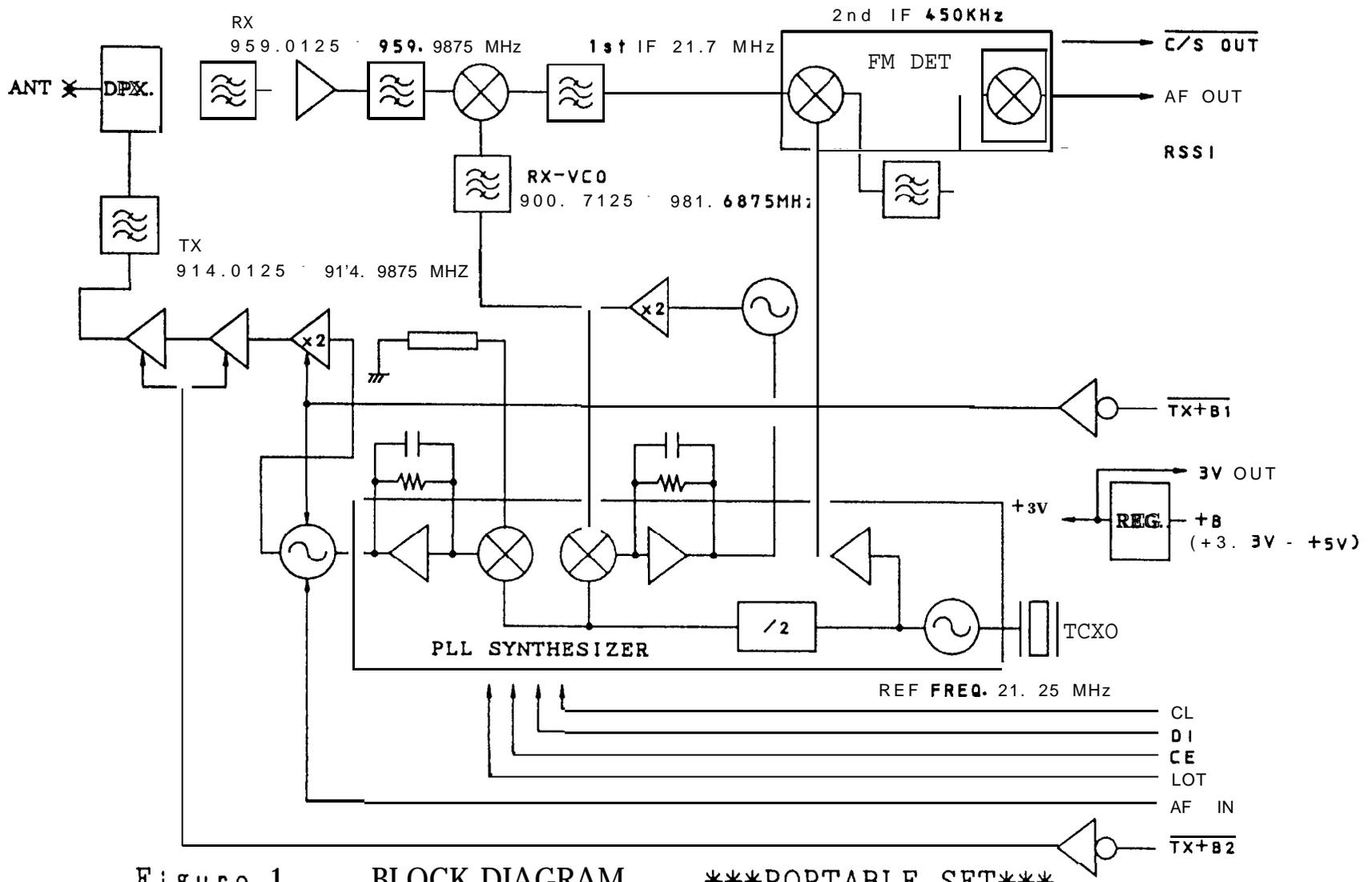


Figure 1 BLOCK DIAGRAM ***PORTABLE SET***

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{Terminal details }

No.	Terminal Name	I/O	Note
1	3.0V OUT	o	Regulator +3.0V output
2	+B	I	Operating voltage input
3	NC	-	No connection
4	AF IN	I	Modulation voice input
5	CL	I	PLL control input (CLOCK)
6	DI	I	PLL control input (DATA)
7	LDT	o	TX lock detect output, active"H"
8	CE	I	PLL control input (ENABLE)
9	TX+B1	I	TX-VCO control input, active"L"
10	GND	-	COMMON GND
11	TX+B2	I	TX-Buffer Amp. control input, active"L"
12	RSSI	o	Receiving signal level detect output
13	C/S OUT	o	Carrier sense output, active"L"
14	AF OUT	o	Demodulation voice output

Table 1

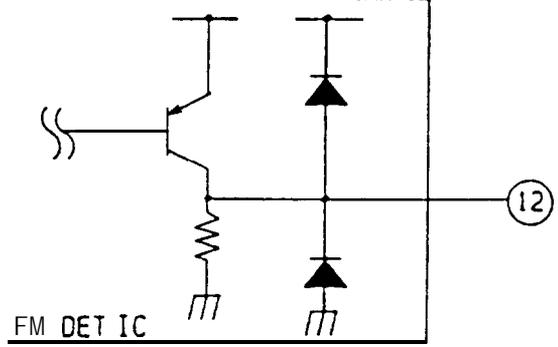
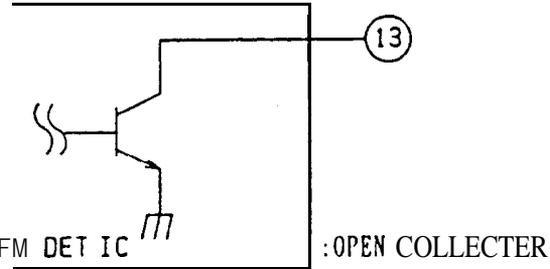
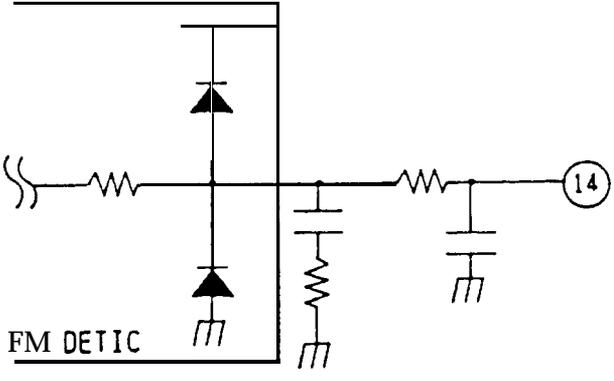
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(Terminal interface references)

No.	Terminal Name	I/O	Interface
1.	3V OUT	o	<p>: MAX OUTPUT CURRENT 5mA</p>
2.	+B	I	
4.	AF IN	I	
5. 6. 8.	CL DI CE	I	<p>PLL IC</p>
7.	LDT	o	<p>: OPEN DRAIN</p>
9. 11.	$\overline{\text{TX+B1}}$ $\overline{\text{TX+B2}}$	I	

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12.	RSSI	0	
13.	$\overline{\text{C/S OUT}}$	0	
14.	AF OUT	0	

* Depend on "No." SHARP RF UNIT SPECIFICATION page 10 "Terminal details",

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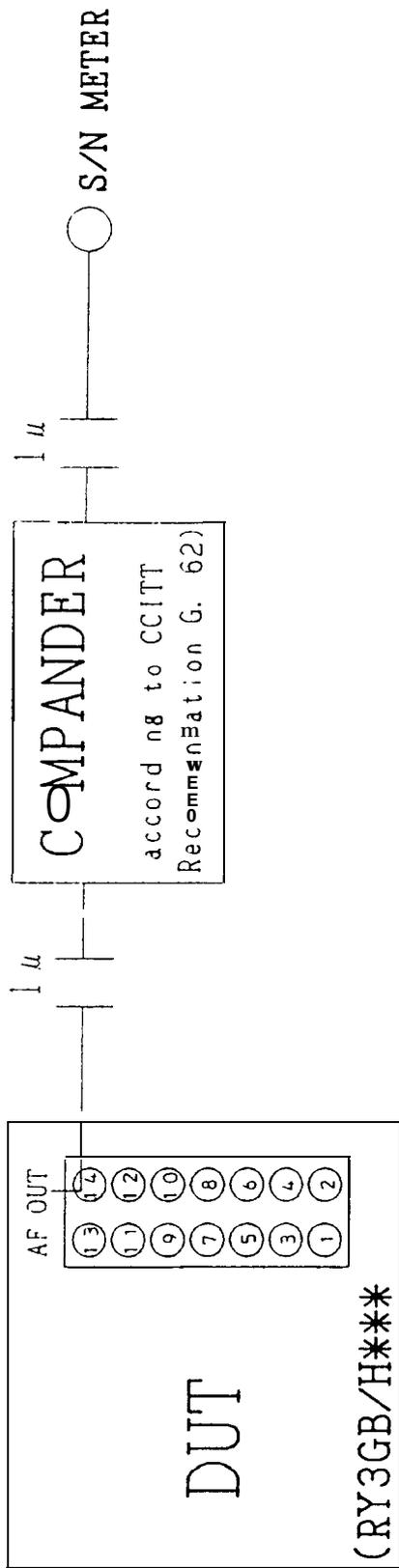
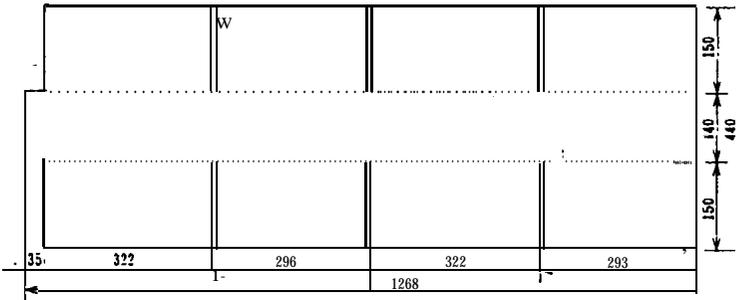


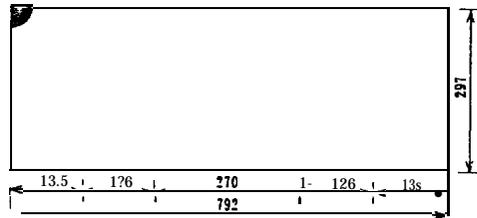
Figure 3 Connection circuit

△ 2-4 Wrapping details

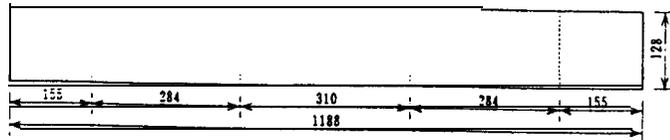
① Wrapping



② paste board

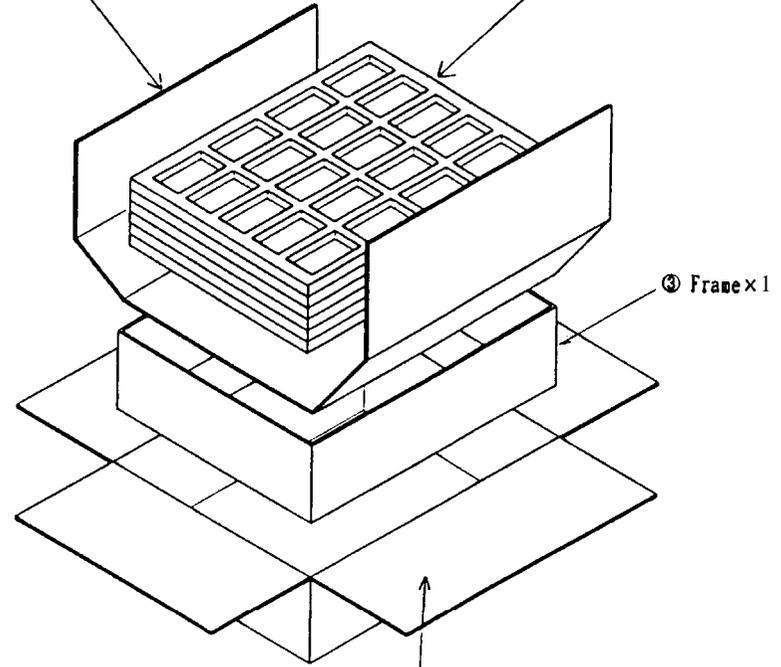


③ Frame



② paste board × 1

Tray × 6



① Wrapping × 1

: 100 pcs./ carton

: top of tray is empty

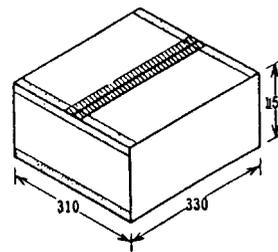


Figure 4

(Unit : mm)